

Notice of References Cited	Application/Control No. 10/537,900	Applicant(s)/Patent Under Reexamination JABLONSKI ET AL.	
	Examiner Dung (Michael) T. Nguyen	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0069669	03-2005	Sakaibara et al.	428/064.4
*	B	US-6,539,041	03-2003	Scheps, Richard	372/53
*	C	US-2004/0109652	06-2004	Risch et al.	385/102
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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